ಸರ್ಕಾರಿ ಪ್ರಥಮ ದರ್ಜೆ ಕಾಲೇಜುಗಳಲ್ಲ ವಿದ್ಯುನ್ಮಾನ ಸಹಾಯಕ ಪ್ರಾಧ್ಯಾಪಕರ ಹುದ್ದೆಗಳನ್ನು ಪರೀಕ್ಷೆ ಮೂಲಕ ತುಂಬಲು ಪಠ್ಯಕ್ರಮ

ವಿಷಯ: ಎಲೆಕ್ಟ್ರಾನಿಕ್ಸ್

Syllabus

UNIT-I

Introduction to Semiconductor, energy bands in solids, concept of effective mass, density of states, Fermi levels. PN Junction, Diode equation and diode equivalent circuit, Breakdown in diodes, Zener diode, Tunnel diode, Metal semiconductor junction – Ohmic and Schottky contacts, Characteristics and equivalent circuits of JFET, MOSFET. Low dimensional semiconductor devices – quantum wells, quantum wires, quantum dots. High Electron Mobility Transistor (HEMT), Solar cells – I-V characteristics, fill factor and efficiency, LED, LCD and flexible display devices.

Emerging materials for future Devices: Graphene, Carbon Nano tubes (CNT), ZnO, SiC etc.

UNIT-II

IC fabrication – crystal growth, epitaxy, oxidation, lithography, doping, etching, isolation methods, metallization, bonding, Thin film deposition and characterization Techniques: XRD, TEM, SEM, EDX, Thin film active and passive devices, MOS technology and VLSI, scaling of MOS devices, NMOS and CMOS structures and fabrication, Characteristics of MOS transistors and threshold voltage, NMOS and CMOS inverters, Charge-Coupled Device (CCD) – structure, charge storage and transfer, Basics of VLSI design, stick diagrams, Layout design rules.

UNIT-III

Superposition, Thevenin, Norton and Maximum Power Transfer Theorems, Network elements, Network graphs, Nodal and Mesh analysis. Laplace Transform, Fourier Transform and Z-transform. Time and frequency domain response, Passive filters, Two-port Network Parameters: Z, Y, ABCD and h parameters, Transfer functions, Signal representation, State variable method of circuit analysis, AC circuit analysis, Transient analysis, Zero and Poles, Bode Plots.

Continuous time signals, Fourier Series and Fourier transform representations, Sampling theorem and applications, Discrete time signal, Discrete Fourier transform (DFT), Fast Fourier transform (FFT), Basic concepts of digital signal processing, digital filters – IIR, FIR.

UNIT-IV

Rectifiers, Voltage regulated ICs and regulated power supply, Biasing of Bipolar junction transistors and FETs, operating point and stability, Amplifiers, Classification of amplifiers, Concept of feedback, Hartley, Colpitt's and Phase Shift oscillators, Operational amplifiers (OPAMP) - characteristics, computational applications, comparators, Schmitt trigger, Instrumentation amplifiers, wave shaping circuits, Phase locked loops, Active filters, Multivibrators, Voltage to frequency convertors (V/F), frequency to voltage convertors (F/V).

UNIT-V

Logic Families, Logic Gates, Boolean algebra and minimization techniques, Combinational circuits, Programmable Logic Devices (PLD), CPLD, flip-flops, memories, Sequential Circuits: Counters – Ring, Ripple, Synchronous, Asynchronous, Shift registers, multiplexers and demultiplexers, A/D and D/A converters, Analysis and Design of fundamental mode state machines: State variables, State table and State diagram. Sequential PLD, FPGA, Analysis and Design of digital circuits using HDL.

UNIT-VI

Introduction of Microprocessor 8086: Architecture, Addressing modes, instruction set, interrupts, Programming, Memory and I/O interfacing.

Introduction of Microcontrollers – 8051 for embedded systems, Architecture and register set of Microcontroller 8051, Addressing modes, Instruction set of 8051 – Data transfer instructions, Arithmetic instructions, Logic instructions, bit level and byte level control transfer instructions, 8051 assembly programming – stack operations, subroutines, interrupts, 8051 programming as timer/counter, 8051 serial communication, 8051 interfacing RS232, LED/LCD display, Keyboard, Stepper motor.

UNIT-VII

Electrostatics - vector calculus, Gauss's Law, Laplace and Poisson's equations, Magnetostatics - Biot Savert's law, Ampere's law and electromagnetic induction, Maxwell's equations and wave equations, Plane wave propagation in free space, dielectrics and conductors, Poynting theorem, Reflection and refraction, polarization, interference, coherence and diffraction, Transmission lines and waveguides - line equations, impedance, reflections and voltage standing wave ratio, rectangular waveguides. Antennas - retarded potential and Hertzian dipole, half wave antenna, antenna patterns, radiation intensity, gain, effective area and Frii's free space receiver power equation.

Microwave Sources and Devices -Reflex Klystron, Magnetron, TWT, Gunn diode, IMPATT diode, Crystal Detector and PIN diode.

Radar - block diagram of Radar, frequencies and power used, Radar range equation.

UNIT-VIII

Analog modulation and demodulation - AM, FM and PM, Principle of super heterodyne receiver, Random signals, noise, noise temperature and noise figure, Basic concepts of information theory, Error detection and correction. Digital modulation and demodulation - PCM, ASK, FSK, PSK, BPSK, QPSK and QAM, Time and Frequency-Division Multiplexing, Multiple Access techniques, Data Communications - Modems, Codes, Principles of Mobile and Satellite Communication, Optical communication, Optical sources - LED, spontaneous and stimulated emission, semiconductor Lasers, Detectors - PIN photodiodes, Avalanche photodiodes (APD), Optical fibers - attenuation and dispersion characteristics, Bandwidth, Wavelength division multiplexing.

Fundamentals of Internet of Things (IoT) for communication.

UNIT-IX

Power devices – characteristics of SCR, DIAC, TRIAC, power transistors, Protection of thyristors against over voltage and over current. SCR triggering - dv/dt and di/dt, triggering with single pulse and train of pulses, A.C. and D.C. motors - construction and speed control. Switched Mode Power Supply (SMPS). Uninterrupted Power Supply (UPS).

Open loop and closed loop control system, Block Diagram reduction techniques, transfer function and signal flow diagram, Stability criterion: Routh-Hurwitz and Nyquist plot, On-off controller, Proportional (P), Proportional-Integral (PI), Proportional-Derivative (PD), PID controllers.

UNIT - X

Transducers – Resistance, Inductance, Capacitance, Piczoelectric, Thermoelectric, Hall effect, Photoelectric, Measurement of displacement, velocity, acceleration, force, torque, strain, temperature, pressure, flow, humidity, thickness, pH. Measuring Equipment – Measurement of R, L and C, Bridge and Potentiometers, voltage, current, power, energy, frequency/time, phase, Digital Multimeters, CRO, Digital Storage Oscilloscope, Spectrum Analyzer., Biomedical Instruments – ECG, EEG, Blood Pressure Measurements, MEMS and its applications Sensors for IoT applications.

UNIT - 4

Exploratory data analysis:

Multivariate normal distribution, Wishart distribution and their properties. Distribution of quadratic forms. Inference for parameters, partial and multiple correlation coefficients and related tests. Data reduction techniques: Principle component analysis, Discriminant analysis, Cluster analysis, Canonical correlation.

Simple random sampling, stratified sampling and systematic sampling. Probability proportional to size sampling. Ratio and regression methods.

Completely randomized designs, randomized block designs and Latin-square designs. Connectedness and orthogonality of block designs, BlBD. 2K factorial experiments: confounding and construction.

Hazard function and failure rates, censoring and life testing, series and parallel systems.

Linear programming problem, simplex methods, duality. Flementary queuing and inventory models. Steady-state solutions of Markovian queuing models: M/M/1, M/M/1 with limited waiting space, M/M/C, M/M/C with limited waiting space, M/G/1.

Numerical Analysis:

Numerical solutions of algebraic equations, Method of iteration and Newton-Raphson method, Rate of convergence, Solution of systems of linear algebraic equations using Gauss elimination and Gauss-Seidel methods, Finite differences, Lagrange, Hermite and spline interpolation, Numerical differentiation and integration, Numerical solutions of ODEs using Picard, Euler, modified Euler and Runge-Kutta methods.

Calculus of Variations:

Variation of a functional, Euler-Lagrange equation, Necessary and sufficient conditions for extrema. Variational methods for boundary value problems in ordinary and partial differential equations.

Linear Integral Equations:

Linear integral equation of the first and second kind of Fredholm and Volterra type, Solutions with separable kernels. Characteristic numbers and eigenfunctions, resolvent kernel.

UNIT - 3

Descriptive Statistics:

Sample space, discrete probability, independent events, Bayes theorem. Random variables and distribution functions (univariate and multivariate); expectation and moments. Independent random variables, marginal and conditional distributions. Characteristic functions. Probability inequalities (Tchebyshef, Markov, Jensen). Modes of convergence, weak and strong laws of large numbers, Central Limit theorems (i.i.d. case).

Markov chains with finite and countable state space, classification of states, limiting behaviour of n-step transition probabilities, stationary distribution, Poisson and birth-and-death processes.

Standard discrete and continuous univariate distributions, sampling distributions, standard errors and asymptotic distributions, distribution of order statistics and range. Methods of estimation, properties of estimators, confidence intervals. Tests of hypotheses: most powerful and uniformly most powerful tests, likelihood ratio tests. Analysis of discrete data and chi-square test of goodness of fit. Large sample tests.

Simple nonparametric tests for one and two sample problems, rank correlation and test for independence. Elementary Bayesian inference.

Gauss-Markov models, estimability of parameters, best linear unbiased estimators, confidence intervals, tests for linear hypotheses. Analysis of variance and covariance. Fixed, random and mixed effects models. Simple and multiple linear regression. Elementary regression diagnostics. Logistic regression.